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LIST OF	REFE	RENCES CITED BY AF	PPLICANT	Hiroyuki KAKIUCHI, et al.			
				FILING DATE		GROUP	
				August 21, 2003		3744	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/CJ/	AA	5,340,563	08/23/1994	Stacey I. ZONES, et al.	1		h n sh
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			FO	REIGN PATENT DOCUMENTS			
	DOCUMENT DATE			COUNTRY		TRANSLATION	
		NUMBER DATE				YES NO	
/CJ/	AO	JP 7-301469	11/14/1995	JAPAN (with English Abstract and Unedited Computer-Generated English Translation)  JAPAN (with English Abstract and Unedited Computer-Generated English Translation)		×	
	AP	JP 9-227249	09/02/1997			×	
	AQ	JP 11-281190	10/15/1999	JAPAN (with English Abstract and Unedited Computer-Generated English Translation)		×	
V	AR	JP 7-501043	02/02/1995	JAPAN (corr. US 5,340,563)			X
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		OTHER R	EFERENCES (	(Including Author, Title, Date, Pertinen	t Pages, e	tc.)	
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Examiner	Examiner /Chen Wen Jiang/ (11/10/2007)				Date Considered		
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